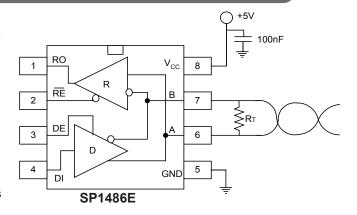




+5V, 20Mbps PROFIBUS RS485/RS422 Transceivers Advanced Failsafe, 1/8th Unit Load, ±15kV ESD-Protected

FEATURES

- Recommended for PROFIBUS applications
- High differential output drive, minimum 2.1V into 54Ω load
- 5.0V Single Supply Operation
- 1ns driver and reveiver skew
- 20 Mbps data rate
- 1/8th Unit Load, 256 transceivers on bus
- Robust ESD Protection for RS485 pins
 - ±15kV Air-Gap Discharge
 - ±15kV Human Body Model
 - ±8kV Contact Discharge
- Hot Swap glitch protection on control inputs
- Receiver failsafe on open, short or terminated lines
- Driver short circuit current limit and thermal shutdown for overload protection
- Very low 300µA static power consumption
- 1µA shutdown mode



APPLICATIONS

- High Speed RS485 Communications
- Industrial Process Control
- PROFIBUS applications

DESCRIPTION

SP1486E is a half duplex differential line transceiver suitable for high speed bidirectional communication on multipoint bus transmission lines. Each device contains one differential driver and one differential receiver. Devices comply with TIA/EIA-485 and TIA/EIA-422 standards and also meet the higher drive and tighter skew requirements of PROFIBUS applications. Lead-free and RoHS compliant packages are available for all models.

PROFIBUS is in wide use in industrial control and automation applications and the SP1486E is ruggedized for use in harsh operating conditions. Receivers are specially designed to fail-safe to a logic high output state if the inputs are left un-driven or shorted. All RS485 bus-pins are protected against severe ESD events up to ±15kV (Air-Gap and Human Body Model) and up to ±8kV Contact Discharge (IEC 1000-4-2). Drivers are protected from excess current flow caused by bus contention or output short-circuits by both an internal current limit and a thermal-overload shutdown. Devices are rated for Industrial (-40 to +85°C) or Extended (-40 to +125°C) operating temperatures. Receivers have exceptionally high input impedance, which places only 1/8th the standard load on a shared bus. Up to 256 transceivers may coexist while preserving full signal margin.

All devices operate from a single 5.0 V power supply and draw negligible quiescent power. Both driver and receiver can be enabled and disabled independently and the device enters a low power shutdown mode if both driver and receiver are disabled. The bus-pin outputs of disabled modules are in high impedance state. The high impedance driver output is maintained over the entire common-mode voltage range from -7 to +12V.

PIN ASSIGNMENTS

Pin Name	Pin Function	Pin Function
1	RO	Receiver Output. When \overline{RE} is low and if $(A - B) \ge -40$ mV, RO is High. If $(A - B) \le -200$ mV, RO is low.
2	RE	Receiver Output Enable. RO is enabled when \overline{RE} is low. When \overline{RE} is high, RO is high impedance. Drive \overline{RE} high and DE low to enter shutdown mode. \overline{RE} is a hot-swap input.
3	DE	Driver Output Enable. When DE is high, outputs are enabled. When DE is low, outputs are high impedance. Drive DE low and RE high to enter shutdown mode. DE is a hot-swap input.
4	DI	Driver Input. With DE high, a low level on DI forces non-inverting output low and inverting output high. Similarly, a high level on DI forces non-inverting output high and inverting output low.
5	GND	Ground
6	А	Non-inverting Receiver Input and Non-inverting Driver Output
7	В	Inverting Receiver Input and Inverting Driver Output
8	Vcc	Positive Supply Vcc. Bypass Vcc to GND with a 0.1uF capacitor.

ABSOLUTE MAXIMUM RATINGS

These are stress ratings only and functional operation of the device at these ratings or any other above those indicated in the operation sections of the specifications below is not implied. Exposure to absolute maximum rating conditions for extended periods of time may affect reliability.

Supply Voltage (Vcc)	+ 7.0V
Input voltage at control input pins (RE, DE)	0.3V to Vcc+0.3V
Driver input voltage (DI)	0.3V to Vcc+0.3V
Driver output voltage (A, B)	+13V
Receiver output voltage (RO)	0.3V to (Vcc + 0.3V)
Receiver input voltage (A, B)	+13V
Package Power Dissipation	450mW @ TA=25°C
Maximum Junction Temperature	150°C
8-Pin SOICN ØJA =	128.4°C/W
Storage Temperature	65°C to +150°C

RECOMMENDED OPERATING CONDITIONS

Vcc=5V ±10%, T_{MIN} to T_{MAX}, unless otherwise noted, Typical values are Vcc=5V and T_A=25°C

Recommended Operating Conditions		Min.	Nom.	Max.	Unit
Supply Voltage, Vcc		4.5	5	5.5	V
Input Voltage on A an	d B pins	-7		12	V
High-level input voltage (DI, DE or RE), VIH		2		Vcc	V
Low-level input voltage (DI, DE or RE), VIL		0		0.8	V
Output Current	Driver	-60		60	mA
	Receiver	-8		8	
Signaling Rate,				20	Mbps
Operating Free Air Temperature, TA	Industrial Grade (E)	-40		85	°C
	Extended Temp Grade (M)	-40		125	
Junction Temperature, TJ		-40		150	°C

Note: The least positive (most negative) limit is designated as the maximum value.

FLECTRICAL CHARACTERISTICS

			EL	ECTRICA	L CHAI	KACIEK	121162	
	PARAMETER	TEST C	CONDITIONS	MIN	TYP	MAX	UNIT	
Digital I	nput Signals: DI, DE, RE						,	
		High, V _{IH}		2.0			.,	
Logic inpu	t thresholds	Low, VIL	Low, VIL			0.8	V	
Logic Inpu	t Current	T _A =25°C, after	er first transition			±1	μA	
Input Hyst	eresis	T _A =25°C			100		mV	
Driver								
Differentia	I Driver Output (VOD)	No Load				Vcc	V	
D:#		RL=100Ω (RS	S422)	2.1		Vcc		
Differentia	I Driver Output	RL=54Ω (RS	485)	2.1	2.7	Vcc	V	
Differentia	I Driver Output	V _{CM} =-7 to +1	2V	2.1	2.7	Vcc	1	
	Magnitude of Differential Output VOD) (Note 1)	RL=54 or 100	Ω			±0.2	٧	
Driver Con	nmon Mode Output Voltage (Voc)	RL=54 or 100Ω				3	V	
Change in Common Mode Output Voltage (ΔVOC)		RL=54 or 100Ω				±0.2	V	
Driver Short Circuit Current Limit		-7V≤Vouт≤+1	I2V			±250	mA	
Receive	r	_ !	,					
Receiver I	nput Resistance	-7V≤Vcм≤12	V	96			ΚΩ	
		<u>DE</u> =0, V _{IN} =12V				125		
Input Curre	ent (A, B pins)	RE=0, Vcc=0 or 5.5V	V _{IN} =-7V	-100			μA	
Receiver D	Differential Threshold (VA-VB)	-7V≤Vcм≤12°	V	-200	-125	-40	mV	
Receiver I	nput Hysteresis				25		mV	
Receiver	Voн	Iоит=-8mA, \	/ _{ID} =-40mV	Vcc-1.5			V	
Voltage	Output Voltage Vol		ID=-200mV			0.4		
High-Z Receiver Output Current		Vcc=5.5V, 0≤Vouт≤Vcc				± 1	μA	
Receiver Output Short Circuit Current		0V≤VRo≤Vcc				± 95	mA	
Supply	and Protection	1		1		1	l.	
Supply	IQ, Active Mode	No load, DI=	0 or Vcc		0.30	1	mA	
Current	Shutdown Mode	DE=0, RE=\	/cc, DI=Vcc or 0			1	μA	
Thermal Shutdown Temperature		Junction tem	perature		165			
Thermal S	hutdown Hysteresis				15		°C	

Notes.

1. Change in Magnitude of Differential Output Voltage and Change in Magnitude of Common Mode Output Voltage are the changes in output voltage when DI input changes state.

2. The transceivers are put into shutdown by bringing RE high and DE low. If the inputs are in this state for less than 50ns the device does not enter shutdown. If the enable inputs are held in this state for at least 600ns the device is assured to be in shutdown. In this low power mode most circuitry is disabled and supply current is typically 1nA.

3. Characterized, not 100% tested

Unless otherwise noted Vcc= +5.0±0.5V, ambient temperature TA from -40 to +85°C

DRIVER CHARACTERISTICS:	Conditions	Min.	Тур.	Max.	Unit
Data Signaling Rate	Duty Cycle 40 to 60%	20			Mbps
Driver Propagation Delay (tphl., tplh)			12	20	ns
Driver Output Rise/Fall Time (t _R , t _F)	Driver Output Rise/Fall Time (t_R , t_F) $R_L = 54\Omega, C_L = 50pF,$		6	10	ns
Driver Differential Skew (t _{PLH} − t _{PHL})			1	5	ns
Driver Enable to Output High (t _{DZH})				50	ns
Driver Enable to Output Low (t_{DZL}) $R_L = 500\Omega$, $C_L = 50pF$,				50	ns
Driver Disable from Output High (tdhz)	ole from Output High (t _{DHZ})			50	ns
Driver Disable from Output Low (t _{DLZ})				50	ns
Shutdown to Driver Output Valid (tozv)				150	ns

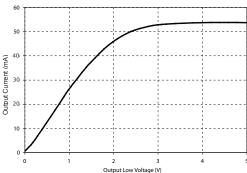
RECEIVER CHARACTERISTICS:	Conditions	Min.	Тур.	Max.	Unit
Data Signaling Rate	Duty Cycle 40 to 60%	20			Mbps
Receiver Propagation Delay (t _{PLH} , t _{PHL})	CL=15pF, VID=±2V,			40	ns
Propagation Delay Skew (tplh, tphl)			1	5	ns
Receiver Output Rise/Fall Time	C _L =15pF			15	ns
Receiver Enable to Output High (tzн)	C _L =15pF, R _L =1kΩ			50	ns
Receiver Enable to Output Low (tzL)	C _L =15pF, R _L =1kΩ			50	ns
Receiver Disable from Output High (thz)	C _L =15pF, R _L =1kΩ			50	ns
Receiver Disable from Output Low (tız)	C _L =15pF, R _L =1kΩ			50	ns
Shutdown to Receiver Output Valid (t _{ROV})				3500	ns
Time to Shutdown (Note 2,3)		50	200	600	ns

- FUNCTION TABLES

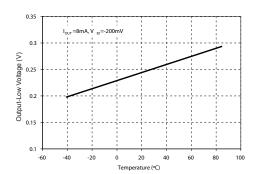
Transmitting					
Inputs			Outputs		
RE	DE	DI	Α	В	
Х	1	1	1	0	
Х	1	0	0	1	
0	0	Х	High-Z		
1	0	Х	Shutdown		

Receiving					
	Inputs				
RE	DE	V _A - V _B	RO		
0	Х	≥ -40mV	1		
0	Х	≤-200mV	0		
0	Х	Open/shorted	1		
1	1	Х	High-Z		
1	0	Х	Shutdown		

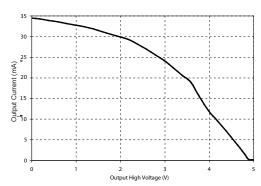
Note: Receiver inputs -200mV < VA - VB $\, < \,$ -40mV, should be considered indeterminate



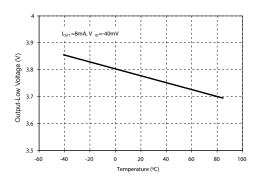
Output Current vs Receiver Output Low Voltage



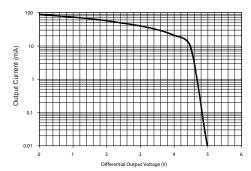
Receiver Output Low Voltage vs Temperature



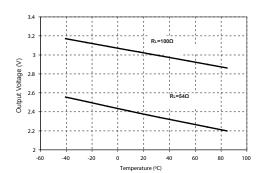
Output Current vs Receiver Output High Voltage



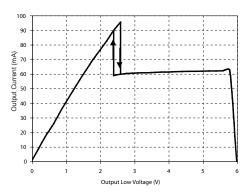
Receiver Output High Voltage vs Temperature



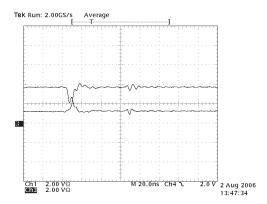
Driver Output Current vs Differential Output Voltage



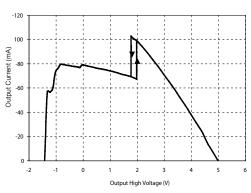
Driver Differential Output Voltage vs Temperature



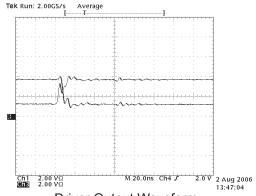
Output Current vs Driver Output Low Voltage



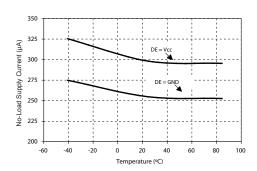
Driver Output Waveforms High to Low



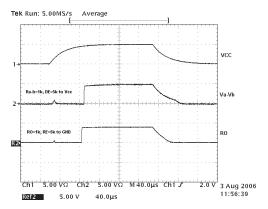
Output Current vs Driver Output High Voltage



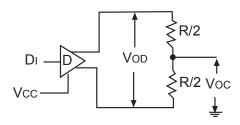
Driver Output Waveform Low to High



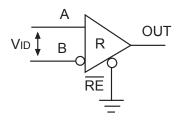
No-load Supply Current vs Temperature



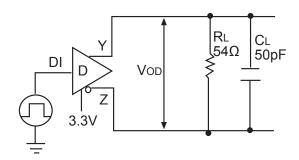
Driver and Receiver Hot Swap Performance vs. Vcc



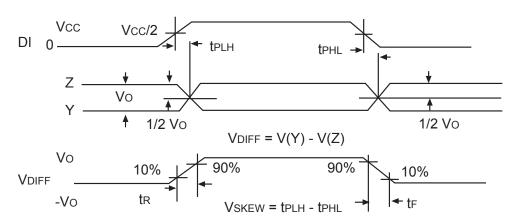
Driver DC Test Circuit



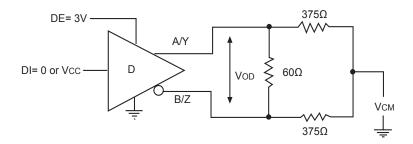
Receiver DC Test Circuit



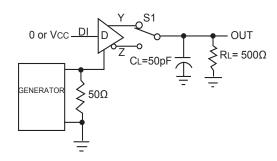
Driver Propagation Delay Time Test Circuit and Timing Diagram

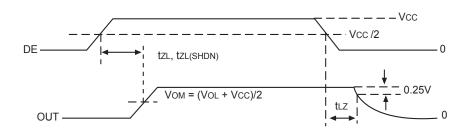


Driver Differential Output Test Circuit

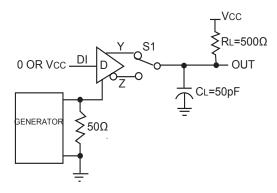


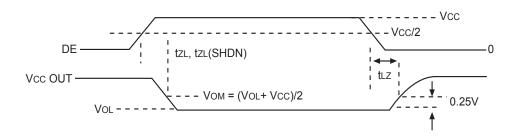
Driver Enable and Disable Times Test Circuit and Timing Diagram



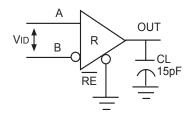


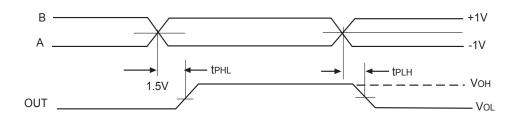
Driver Enable and Disable Times Test Circuit and Timing Diagram



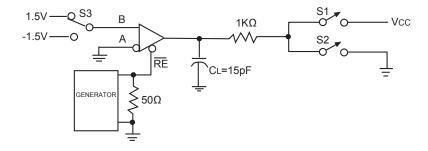


Receiver Propagation Delay Test Circuit and Timing Diagram

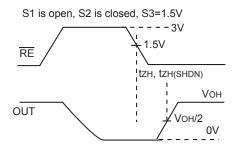


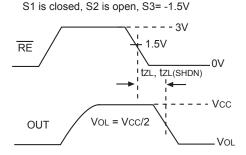


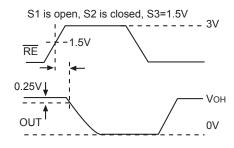
Receiver Enable and Disable Times Test Circuit

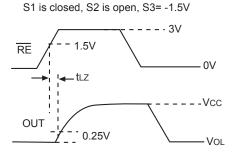


Receiver Enable and DisableTiming Diagram









DETAILED DESCRIPTION

SP1486E is an advanced RS485/RS422 transceiver, ideal for PROFIBUS applications. Each device contains one high speed driver and receiver capable of speeds up to 20Mbps with low skew.

The device is designed for reliability in demanding operating conditions. It features a fail-safe circuitry that guarantees a logic-high receiver output when the receiver inputs are open or shorted, or when they are connected to a terminated transmission line with all drivers disabled. Control inputs (DE and RE) also feature a hotswap capability allowing live insertion without error data transfer.

The device operates from a single 5.0V supply. Drivers are output short-circuit current limited. Thermal-shutdown circuitry protects drivers against excessive power dissipation. When activated, the thermal-shutdown circuitry places the driver outputs into a high-impedance state.

PROFIBUS (EN50170 or DIN19245)

The PROFIBUS standard originated in Europe but has spread worldwide as an industrial field-bus for use in process automation and factory control. There are a number of different implementations, but one of the most widely used is PROFIBUS-DP (Process Field Bus - Distributed Peripherals). DP uses RS485 as its physical layer along with a proprietary data-link layer.

ADVANCED FAIL SAFE

Ordinary RS485 differential receivers will be in an indeterminate state whenever A - B is less than ±200mV. This situation can occur whenever the data bus is not being actively driven. The Advanced Failsafe feature of the SP1486E guarantees a logic-high receiver output if the receiver's differential inputs are shorted, opencircuit, or if they are shunted by a termination resistor.

The receiver thresholds of the SP1486E are very precise and offset by at least a 40mV noise margin from ground. This results in a logic-high receiver output at zero volts input differential while maintaining compliance with the EIA/TIA-485 standard of ±200mV.

HOT-SWAP CAPABILITY

When a micro-processor or other logic device undergoes its power-up sequence its logic-outputs are typically at high impedance. In this state they are unable to drive the DE and RE signals to a defined logic level. During this period, noise, parasitic coupling or leakage from other devices could cause standard CMOS enable inputs to drift to an incorrect logic level.

If circuit boards are inserted into an energized backplane (commonly called "live insertion" or "hot-swap") power may be suddenly applied to all circuits. Without the hot-swap capability, this situation could improperly enable the transceiver's driver or receiver, driving invalid data onto shared busses and possibly causing driver contention or device damage.

The SP1486E contains a special power-on-reset circuit that holds DE low and RE high for approximately 10 microseconds. After this initial power-up sequence the hot-swap circuit becomes transparent, allowing for normal, unskewed enable and disable timings.

±15KV ESD PROTECTION

ESD-protection structures are incorporated on all pins to protect against electrostatic discharges encountered during handling and assembly. The driver output and receiver inputs have extra protection against static electricity. Sipex uses state of the art structures to protect these pins against ESD of ±15kV without damage. The ESD structures withstand high ESD in all states: normal operation, shutdown, and powered down. After an ESD event, the SP1486E keeps working without latch-up or damage.

ESD protection can be tested in various ways. The transmitter outputs and receiver inputs of the SP1486E are characterized for protection to the following limits

- ±15kV using the Human Body Model
- ±8kV using the Contact Discharge method specified in IEC 1000-4-2
- ±15kV Air-gap

IEC 1000-4-2

The IEC 1000-4-2 standard covers ESD testing and performance of finished equipment. However, it does not specifically refer to integrated circuits. The SP1486E helps you design equipment to meet IEC 1000-4-2, without sacrificing board-space and cost for external ESD-protection components.

The major difference between tests done using the Human Body Model and IEC 1000-4-2 is a higher peak current in IEC 1000-4-2. Series resistance is lower in the IEC 1000-4-2 model. Hence, the ESD withstand voltage measured to EC 1000-4-2 is generally lower than that measured using the human body model.

The air-gap test involves approaching the device with a charged probe. The contact discharge method connects the probe to the device before the probe is energized.

MACHINE MODEL

The machine model for ESD tests all pins using a 200pF storage capacitor and zero discharge resistance. The objective is to emulate the stress caused when I/O pins are contacted by handling equipment during test and assembly.

256 TRANSCEIVERS ON THE BUS

The standard RS485 receiver input impedance is $12k\Omega$ (1 unit load). A standard driver can drive up to 32 unit loads. The SP1486E has only a 1/8th unit load receiver input impedance (96k Ω), thereby allowing eight times as many, up to 256, transceivers to be connected in parallel on a communication line. Any combination of these devices and other RS485 transceivers up to a total of 32 unit loads may be connected to the line

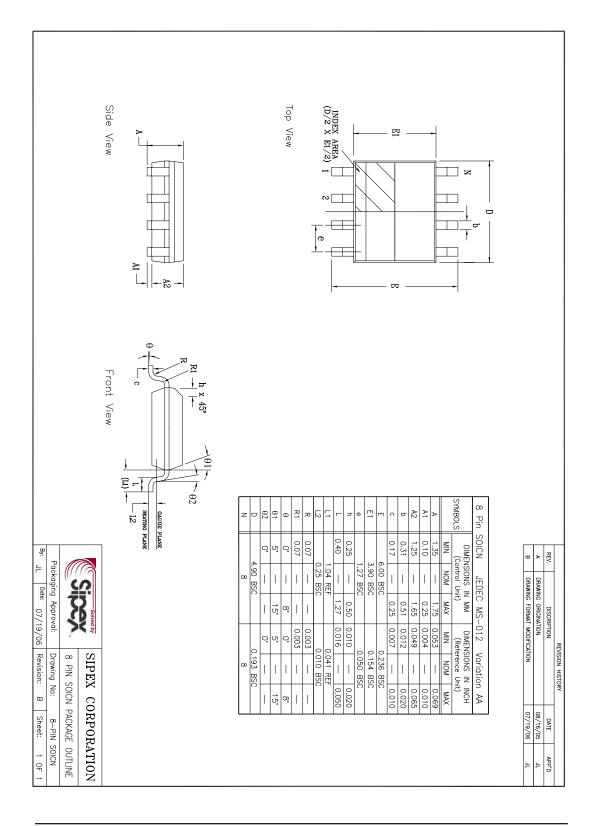
LOW POWER SHUTDOWN MODE

Low-power shutdown mode is initiated by bringing both \overline{RE} high and DE low simultaneously. While in shutdown devices typically draw only 50nA of supply current. DE and \overline{RE} may be tied together and driven by a single control signal. Devices are guaranteed not to enter shutdown if \overline{RE} is high and DE is low for less than 50ns. If the inputs are in this state for at least 600ns, the parts are shut-down.

Enable times tzH and tzL apply when the part is not in low-power shutdown state. Enable times tzH(SHDN) and tzL(SHDN) apply when the parts are shut down. The drivers and receivers take longer to become enabled from low-power shutdown mode tzH(SHDN) and tzL(SHDN) than from driver/receiver-disable mode (tzH, tzL).

DRIVER OUTPUT PROTECTION

Two mechanisms prevent excessive output current and power dissipation caused by faults or by bus contention. First, a driver-current limit on the output stage provides immediate protection against short circuits over the whole common-mode voltage range. Second, a thermal-shutdown circuit forces the driver outputs into a high-impedance state if junction temperature becomes excessive.



ORDERING INFORMATION

Part number	Temperature range	Package Type
SP1486EEN-L	From -40 to +85°C	Lead Free NSOIC 8 pin
SP1486EMN-L	From -40 to +125°C	Lead Free NSOIC 8 pin

For availability of "M" temperatures (-40 to +125°C) or in other packages contact factory.

For Tape and Reel add "/TR". Example: SP1486EEN-L/TR = lead free and Tape and Reel. SP1486EEN/TR = standard in Tape and Reel.

Reel quantity is 2,500 for NSOIC.



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